**Triacs** logic level BT136X series D

## **GENERAL DESCRIPTION**

## **QUICK REFERENCE DATA**

Passivated, sensitive gate triacs in a full pack plastic envelope, intended for use general purpose bidirectional switching and phase control applications. These devices are intended be interfaced directly microcontrollers, logic integrated circuits and other low power gate trigger circuits.

SYMBOL	PARAMETER	MAX.	UNIT
V <sub>DRM</sub> I <sub>T(RMS)</sub> I <sub>TSM</sub>	Repetitive peak off-state voltages RMS on-state current Non-repetitive peak on-state current	<b>600D</b> 600 4 25	V A A

## **PINNING - SOT186A**

PIN

1

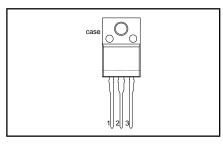
2

3

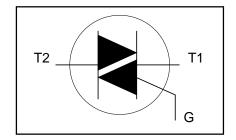
case

DESCRIPTION
main terminal 1
main terminal 2
gate

## **PIN CONFIGURATION**



## **SYMBOL**



## LIMITING VALUES

isolated

Limiting values in accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{DRM}$	Repetitive peak off-state voltages		-	<b>-600</b> 600	V
I <sub>T(RMS)</sub>	RMS on-state current Non-repetitive peak on-state current	full sine wave; $T_{hs} \le 92 ^{\circ}C$ full sine wave; $T_{j} = 25 ^{\circ}C$ prior to surge	-	4	А
		t = 20 ms t = 16.7 ms	-	25 27	A A
l <sup>2</sup> t dl <sub>T</sub> /dt	I <sup>2</sup> t for fusing Repetitive rate of rise of on-state current after	t = 10.7  ms t = 10  ms $I_{TM} = 6 \text{ A}; I_{G} = 0.2 \text{ A};$ $dI_{G}/dt = 0.2 \text{ A}/\mu\text{s}$	-	3.1	A <sup>2</sup> s
	triggering	T2+ G+ T2+ G- T2- G- T2- G+	-	50 50 50 10	A/μs A/μs A/μs A/μs
I <sub>GM</sub> V <sub>GM</sub> P <sub>GM</sub>	Peak gate current Peak gate voltage Peak gate power		-	2 5 5	Å V W
$ \begin{array}{c} P_{G(AV)} \\ T_{stg} \\ T_{j} \end{array} $	Average gate power Storage temperature Operating junction temperature	over any 20 ms period	-40 -	0.5 150 125	ůů. M

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# **ISOLATION LIMITING VALUE & CHARACTERISTIC**

 $T_{hs}$  = 25 °C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>isol</sub>	R.M.S. isolation voltage from all three terminals to external heatsink	f = 50-60 Hz; sinusoidal waveform; R.H. ≤ 65%; clean and dustfree	-	ı	2500	>
C <sub>isol</sub>	Capacitance from T2 to external heatsink	f = 1 MHz	-	10	-	pF

## THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
R <sub>th i-a</sub>		full or half cycle with heatsink compound without heatsink compound in free air	- - -	- - 55	5.5 7.2 -	K/W K/W K/W

## STATIC CHARACTERISTICS

T<sub>i</sub> = 25 °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I <sub>GT</sub>	Gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}$				
01		T2+ G+	-	2.0	5	mΑ
		T2+ G-	-	2.5	5	mΑ
		T2- G-	-	2.5	5	mΑ
		T2- G+	-	5.0	10	mΑ
$  \mathbf{I}_{L}  $	Latching current	$V_{\rm D} = 12 \text{ V}; I_{\rm GT} = 0.1 \text{ A}$				
_		T2+ G+	-	1.6	10	mΑ
		T2+ G-	-	4.5	15	mΑ
		T2- G-	-	1.2	10	mΑ
		T2- G+	-	2.2	15	mΑ
I <sub>H</sub>	Holding current	$V_D = 12 \text{ V}; I_{GT} = 0.1 \text{ A}$	-	1.2	10	mΑ
$\left[ egin{array}{c} oldsymbol{I}_H \ oldsymbol{V}_T \end{array}  ight]$	On-state voltage	I <sub>T</sub> = 5 A	-	1.4	1.70	V
$V_{GT}$	Gate trigger voltage	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}$	-	0.7	1.5	V
		$V_D = 400 \text{ V}; I_T = 0.1 \text{ A}; T_L = 125 ^{\circ}\text{C}$	0.25	0.4	-	V
$I_{D}$	Off-state leakage current	$V_D = V_{DRM(max)}$ ; $T_i = 125  ^{\circ}C$	-	0.1	0.5	mΑ

## **DYNAMIC CHARACTERISTICS**

T<sub>i</sub> = 25 °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
dV <sub>D</sub> /dt	Critical rate of rise of off-state voltage	$V_{DM} = 67\% V_{DRM(max)}; T_j = 125 °C;$ exponential waveform; $R_{GK} = 1 k\Omega$	-	5	-	V/µs
<b>t</b> <sub>gt</sub>	Gate controlled turn-on time	$I_{TM} = 6 \text{ A}; V_D = V_{DRM(max)}; I_G = 0.1 \text{ A}; $ $dI_G/dt = 5 \text{ A}/\mu\text{s}$	-	2	-	μs

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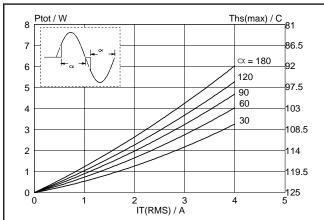


Fig.1. Maximum on-state dissipation,  $P_{tot}$ , versus rms on-state current,  $I_{T(RMS)}$ , where  $\alpha =$  conduction angle.

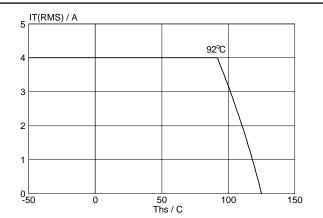


Fig.4. Maximum permissible rms current  $I_{T(RMS)}$ , versus heatsink temperature  $T_{hs}$ .

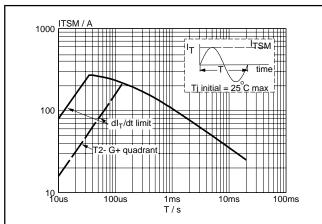


Fig.2. Maximum permissible non-repetitive peak on-state current  $I_{TSM}$ , versus pulse width  $t_p$ , for sinusoidal currents,  $t_p \le 20$ ms.

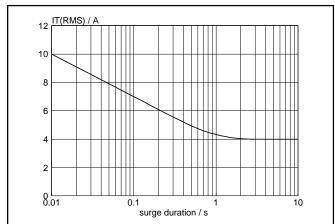


Fig.5. Maximum permissible repetitive rms on-state current  $I_{T(RMS)}$ , versus surge duration, for sinusoidal currents, f = 50 Hz;  $T_{hs} \le 92$  °C.

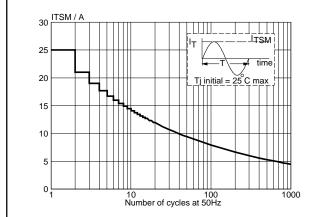


Fig.3. Maximum permissible non-repetitive peak on-state current  $I_{TSM}$ , versus number of cycles, for sinusoidal currents, f = 50 Hz.

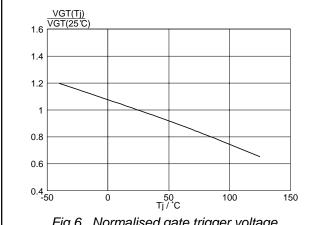
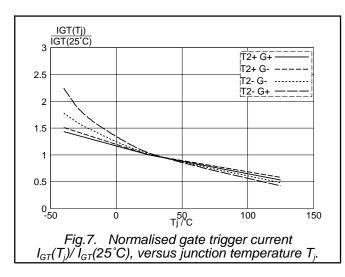
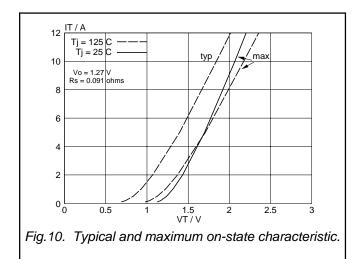


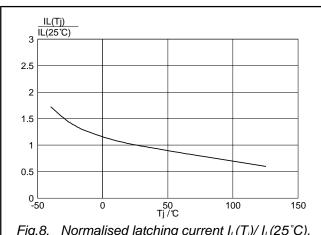
Fig.6. Normalised gate trigger voltage  $V_{GT}(T_j)/V_{GT}(25^{\circ}C)$ , versus junction temperature  $T_j$ .

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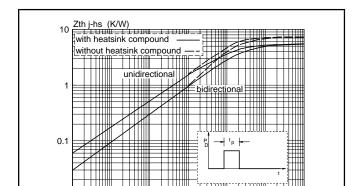
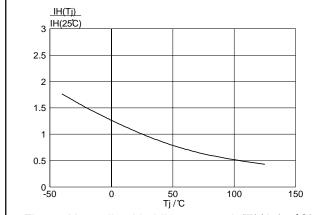


Fig.8. Normalised latching current  $I_L(T_j)/I_L(25^{\circ}\text{C})$ , versus junction temperature  $T_j$ .

Fig.11. Transient thermal impedance  $Z_{th j-hs}$ , versus pulse width  $t_o$ .

0.1ms



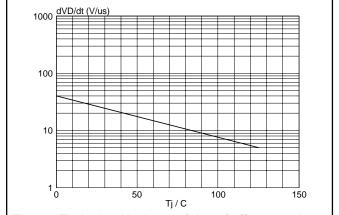
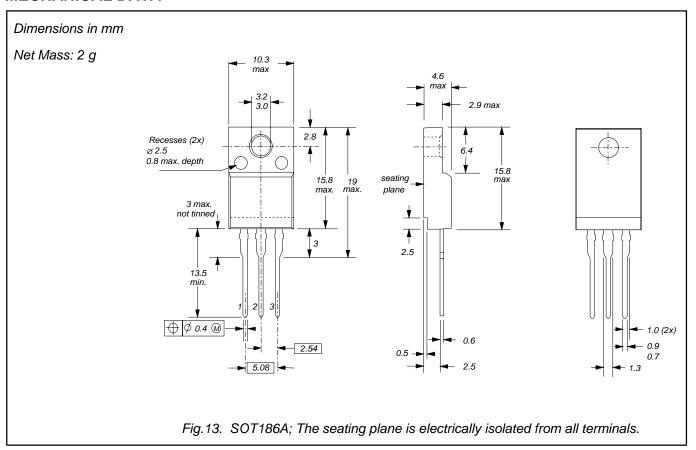


Fig.9. Normalised holding current  $I_H(T_i)/I_H(25^{\circ}C)$ , versus junction temperature  $T_i$ .

Fig.12. Typical, critical rate of rise of off-state voltage, dV<sub>D</sub>/dt versus junction temperature T<sub>i</sub>.

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## **MECHANICAL DATA**



- Refer to mounting instructions for F-pack envelopes.
   Epoxy meets UL94 V0 at 1/8".

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## **DEFINITIONS**

DATA SHEET STATUS				
DATA SHEET STATUS <sup>1</sup>	PRODUCT STATUS <sup>2</sup>	DEFINITIONS		
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice		
Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in ordere to improve the design and supply the best possible product		
Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Changes will be communicated according to the Customer Product/Process Change Notification (CPCN) procedure SNW-SQ-650A		

Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

## Application information

Where application information is given, it is advisory and does not form part of the specification.

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